Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/693,896	CHEN ET AL.	
Examiner	Art Unit	
Stephen W. Smoot	2813	

SEARCHED			
Class	Subclass	Date	Examiner
438	108	1/27/2005	sws
438	612	1/27/2005	sws
438	613	1/27/2005	sws
438	614	1/27/2005	sws
257	738	1/27/2005	sws
257	E21.508	1/27/2005	sws
29	842	1/27/2005	sws

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1.			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
-	DATE	EXMR	
Key Words: Solder Ball, Bump - Flux; Active Surface; Bond Pad; Under Bump Metallurgy;	1/27/2005	II).J. sws	
Passivation Layer; Solder Reflow; Solid Flux.	1/27/2005	L.J. sws	
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Search Tools - EAST (attached): USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB	1/27/2005	LUL,	
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